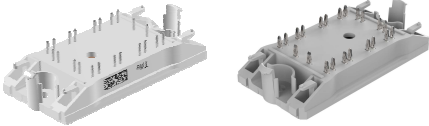
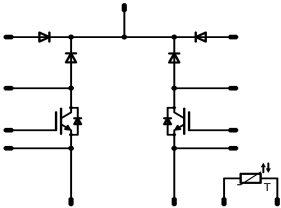




<i>flow BOOST 0</i>	1200 V / 40 A
<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; margin: 0;"><b>Features</b></p> <ul style="list-style-type: none"> <li>High efficiency dual boost</li> <li>Ultra fast switching frequency</li> <li>Low Inductance Layout</li> <li>1200V IGBT and 1200V SiC diode</li> <li>Antiparallel IGBT protection diode with high current</li> </ul> </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; margin: 0;"><b>Target Applications</b></p> <ul style="list-style-type: none"> <li>solar inverter</li> </ul> </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; margin: 0;"><b>Types</b></p> <ul style="list-style-type: none"> <li>V23990-P629-L63-PM</li> <li>V23990-P629-L63Y-PM</li> </ul> </div>	<div style="border: 1px solid black; padding: 5px; margin-bottom: 5px;"> <p style="text-align: center; margin: 0;"><i>flow 0 12mm housing</i></p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; margin: 0;"><b>Schematic</b></p>  </div>

## Maximum Ratings

$T_j=25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit	
<b>Bypass Diode\ Input Boost Prot. Diode</b>					
Repetitive peak reverse voltage	$V_{RRM}$		1600	V	
Mean forward current	$I_{FAV}$	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	38	A
			$T_c = 80^{\circ}\text{C}$	45	
Surge (non-repetitive) forward current	$I_{FSM}$	$t_p = 10\text{ms}$	220	A	
I <sup>2</sup> t-value	$I^2t$	$T_j = 25^{\circ}\text{C}$	200	A <sup>2</sup> s	
Power dissipation	$P_{tot}$	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	47	W
			$T_c = 80^{\circ}\text{C}$	71	
Maximum Junction Temperature	$T_{jmax}$		150	°C	

### Input Boost IGBT

Collector-emitter break down voltage	$V_{CES}$		1200	V	
DC collector current	$I_C$	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	43	A
			$T_c = 80^{\circ}\text{C}$	57	
Repetitive peak collector current	$I_{CRM}$	$t_p$ limited by $T_{jmax}$	160	A	
Power dissipation	$P_{tot}$	$T_j = T_{jmax}$	$T_s = 80^{\circ}\text{C}$	145	W
			$T_c = 80^{\circ}\text{C}$	220	
Gate-emitter peak voltage	$V_{GE}$		±20	V	
Short circuit ratings	$t_{SC}$	$T_j \leq 150^{\circ}\text{C}$	10	µs	
	$V_{CC}$	$V_{GE} = 15\text{V}$	600	V	
Maximum Junction Temperature	$T_{jmax}$		150	°C	



## Maximum Ratings

 $T_j=25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
-----------	--------	-----------	-------	------

### Input Boost FWD

Peak Repetitive Reverse Voltage	$V_{RRM}$		1200	V
Mean forward current	$I_{FAV}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	28 34	A
Surge (non-repetitive) forward current	$I_{FSM}$	$t_p=10\text{ms}$ $T_j=25^{\circ}\text{C}$	138	A
I <sup>2</sup> t-value	$I^2t$		95	A <sup>2</sup> s
Repetitive peak forward current	$I_{FRM}$	$t_p$ limited by $T_{jmax}$	78	A
Power dissipation	$P_{tot}$	$T_j=T_{jmax}$ $T_s=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	81 123	W
Maximum Junction Temperature	$T_{jmax}$		175	$^{\circ}\text{C}$

### Thermal Properties

Storage temperature	$T_{sig}$		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	$T_{op}$		-40...+( $T_{jmax} - 25$ )	$^{\circ}\text{C}$

### Insulation Properties

Insulation voltage		$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			9,55	mm
Comparative Tracking Index	CTI		>200	



### Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}$ [V] or $V_{GS}$ [V]	$V_r$ [V] or $V_{CE}$ [V] or $V_{DS}$ [V]	$I_C$ [A] or $I_F$ [A] or $I_D$ [A]	$T_j$ [°C]	Min	Typ	Max		

#### Bypass Diode\Input Boost Prot. Diode

Forward voltage	$V_F$				25	25 125	0,8	1,14 1,10	1,9	V
Threshold voltage (for power loss calc. only)	$V_{to}$				25	25 125		0,92 0,80		V
Slope resistance (for power loss calc. only)	$r_t$				25	25 125		0,009 0,012		$\Omega$
Reverse current	$I_r$			1600		25 125			0,05	mA
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						1,49		K/W
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease tickness $\leq 50\mu m$ $\lambda= 1 W/K$						1,73		K/W

#### Input Boost IGBT

Gate emitter threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}$				0,00025	25 125	3,5	5,5	7,5	V
Collector-emitter saturation voltage	$V_{CEsat}$		15			50	25 125	1,5	2,89 3,09	3,2	V
Collector-emitter cut-off	$I_{CES}$		0	1200			25 125			1	mA
Gate-emitter leakage current	$I_{GES}$		20	0			25 125	250		250	nA
Integrated Gate resistor	$R_{gint}$							none			$\Omega$
Turn-on delay time	$t_{d(on)}$						25 125	24 23			ns
Rise time	$t_r$						25 125	9 11			
Turn-off delay time	$t_{d(off)}$	$R_{goff}=4 \Omega$	15	700	40		25 125	178 208			
Fall time	$t_f$	$R_{gon}=4 \Omega$					25 125	11 39			
Turn-on energy loss	$E_{on}$						25 125	0,467 0,550			mWs
Turn-off energy loss	$E_{off}$						25 125	0,934 1,760			
Input capacitance	$C_{ies}$							3200			pF
Output capacitance	$C_{oss}$	$f=1MHz$	0	25		25		370			
Reverse transfer capacitance	$C_{rss}$							125			
Gate charge	$Q_G$		15	600	40	25		220	330		nC
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						0,65			K/W
Thermal resistance junction to sink	$R_{th(j-s)}$	Thermal grease tickness $\leq 50\mu m$ $\lambda= 1 W/K$						0,79			K/W

#### Input Boost FWD

Forward voltage	$V_F$				15	25 125		1,43 1,69	2		V
Reverse leakage current	$I_{rm}$			1200		25 125			150		$\mu A$
Peak recovery current	$I_{RRM}$					25 125		17 15			A
Reverse recovery time	$t_{rr}$					25 125		10 9			ns
Reverse recovery charge	$Q_{rr}$	$R_{gon}=4 \Omega$	15	700	40	25 125		0,116 0,109			$\mu C$
Reverse recovered energy	$E_{rec}$					25 125		0,016 0,014			mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125		6570 5559			A/ $\mu s$
Thermal resistance junction to sink	$R_{th(j-s)}$	phase-change material $\lambda=3,4W/mK$						1,17			K/W
Thermal resistance junction to case	$R_{th(j-s)}$	Thermal grease tickness $\leq 50\mu m$ $\lambda= 1 W/K$						1,36			K/W



### Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}$ [V] or $V_{GS}$ [V]	$V_r$ [V] or $V_{CE}$ [V] or $V_{DS}$ [V]	$I_C$ [A] or $I_F$ [A] or $I_D$ [A]	$T_j$ [°C]	Min	Typ	Max		

#### Thermistor

Rated resistance	$R$					T=25		22		kΩ
Deviation of R100	$\Delta_{R/R}$	$R_{100}=1486 \Omega$				T=100	-12		+14	%
Power dissipation	$P$					T=25		200		mW
Power dissipation constant						T=25		2		mW/K
B-value	$B_{(25/50)}$	Tol. $\pm 3\%$				T=25		3950		K
B-value	$B_{(25/100)}$	Tol. $\pm 3\%$				T=25		3998		K
Vincotech NTC Reference									B	

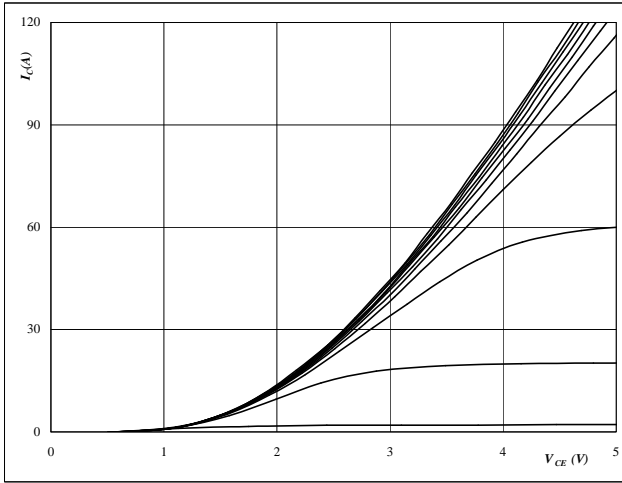


# Input Boost IGBT / Input Boost FWD

**Figure 1** IGBT

**Typical output characteristics**

$I_C = f(V_{CE})$

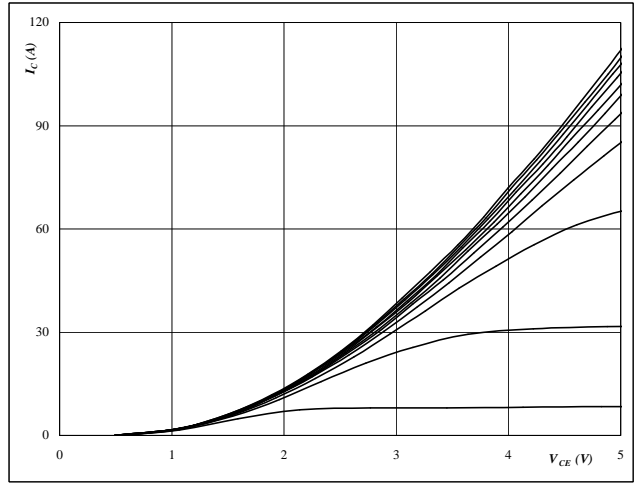


**At**  
 $t_p = 250 \mu s$   
 $T_j = 25 \text{ } ^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 2** IGBT

**Typical output characteristics**

$I_C = f(V_{CE})$

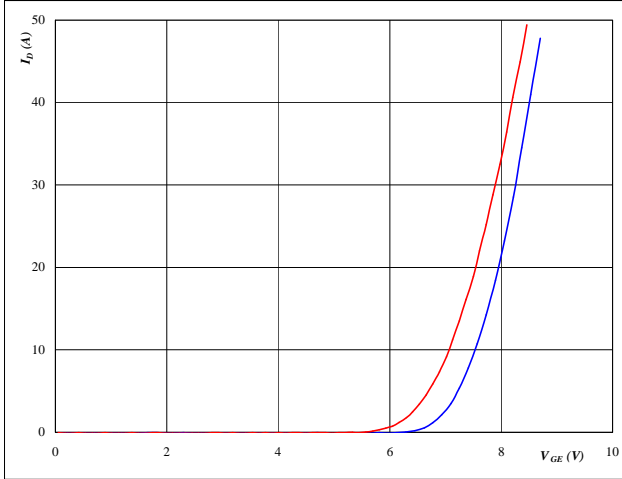


**At**  
 $t_p = 250 \mu s$   
 $T_j = 126 \text{ } ^\circ C$   
 $V_{GE}$  from 7 V to 17 V in steps of 1 V

**Figure 3** IGBT

**Typical transfer characteristics**

$I_C = f(V_{GE})$

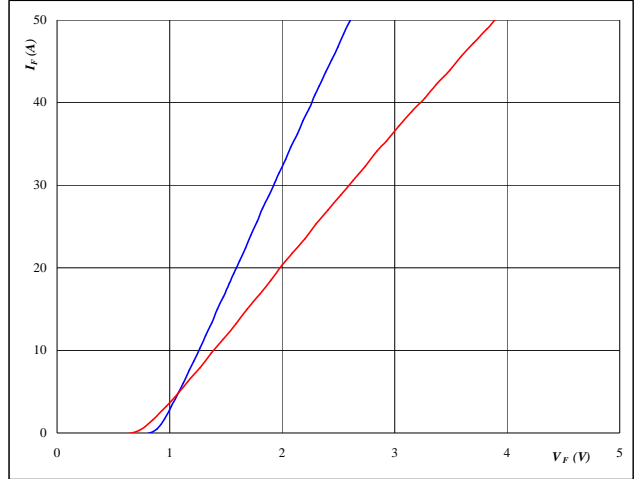


**At**  
 $t_p = 100 \mu s$   
 $V_{CE} = 10 V$   
 $T_j = 25/125 \text{ } ^\circ C$

**Figure 4** IGBT

**Typical diode forward current as a function of forward voltage**

$I_F = f(V_F)$



**At**  
 $t_p = 250 \mu s$   
 $T_j = 25/125 \text{ } ^\circ C$

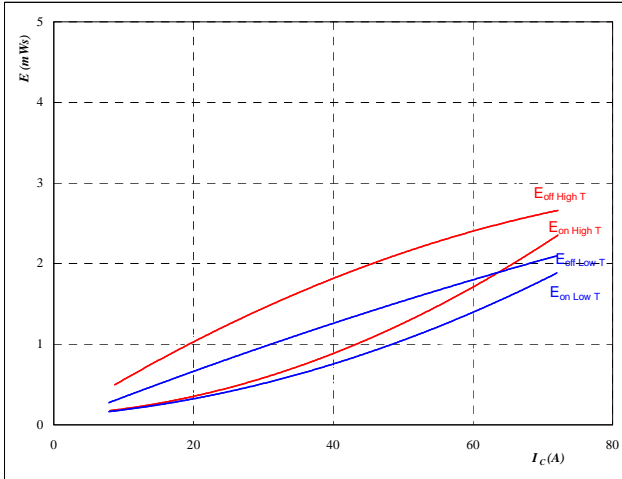


## Input Boost IGBT / Input Boost FWD

**Figure 5** IGBT

Typical switching energy losses  
as a function of collector current

$$E = f(I_C)$$



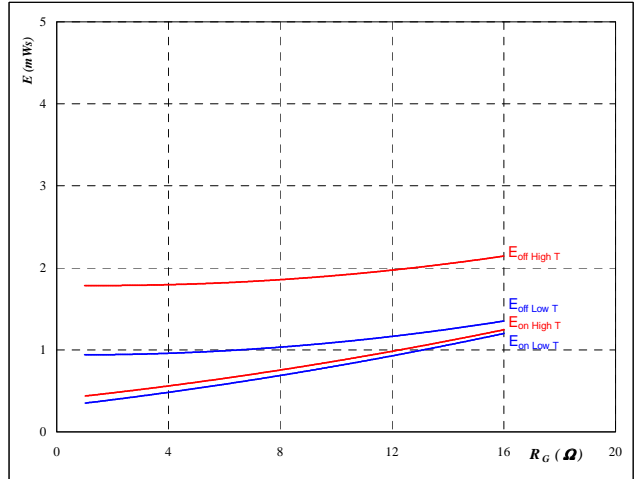
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $R_{gon} = 4$  Ω  
 $R_{goff} = 4$  Ω

**Figure 6** IGBT

Typical switching energy losses  
as a function of gate resistor

$$E = f(R_G)$$



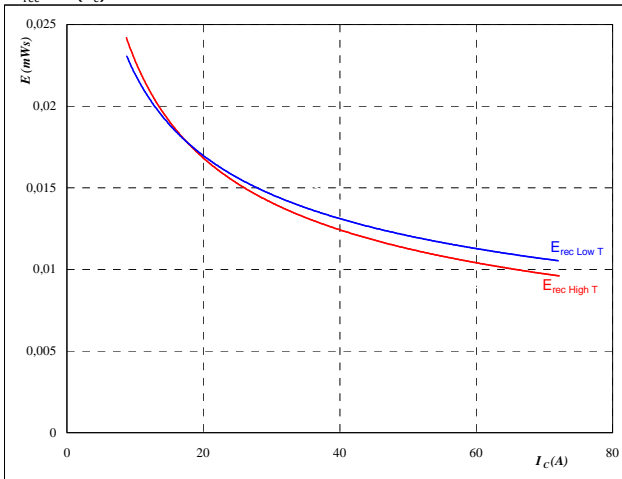
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $I_C = 40$  A

**Figure 7** FWD

Typical reverse recovery energy loss  
as a function of collector current

$$E_{rec} = f(I_C)$$



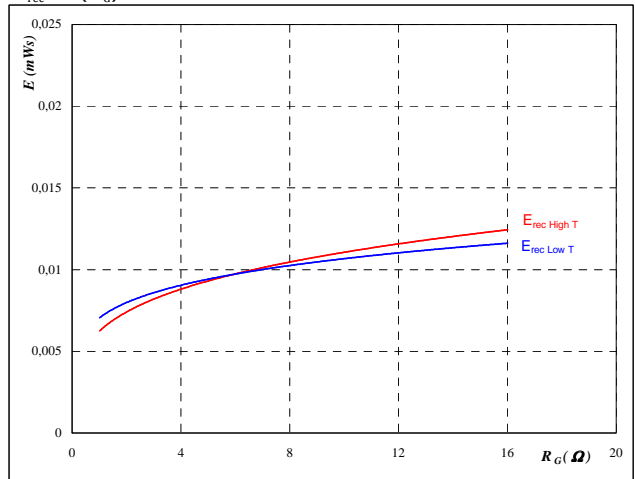
With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $R_{gon} = 4$  Ω  
 $R_{goff} = 4$  Ω

**Figure 8** FWD

Typical reverse recovery energy loss  
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

$T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $I_C = 40$  A

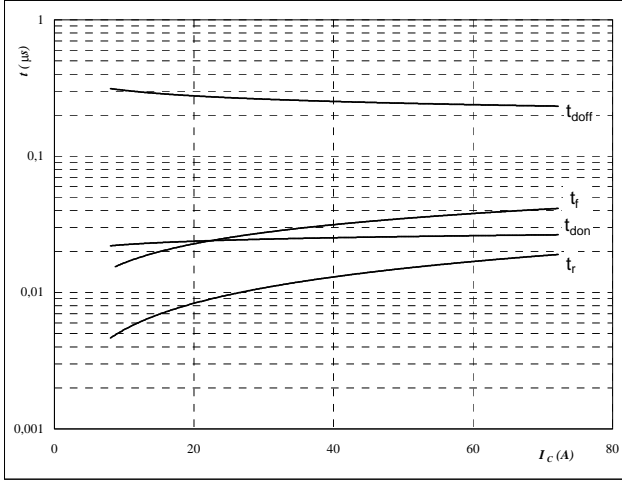


## Input Boost IGBT / Input Boost FWD

**Figure 9** IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



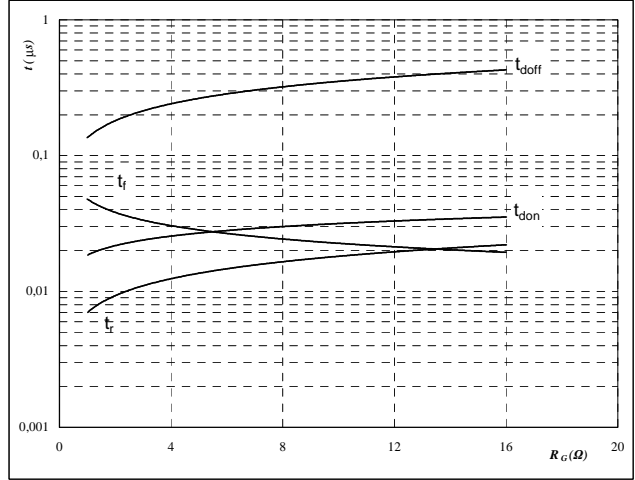
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	700	V
$V_{GE} =$	15	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

**Figure 10** IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



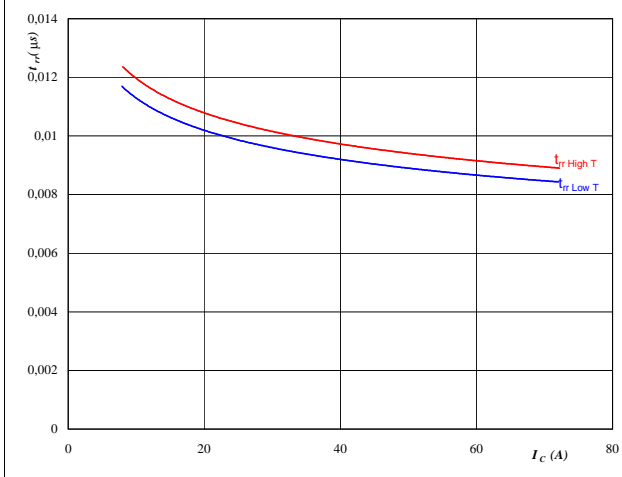
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	700	V
$V_{GE} =$	15	V
$I_C =$	40	A

**Figure 11** FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



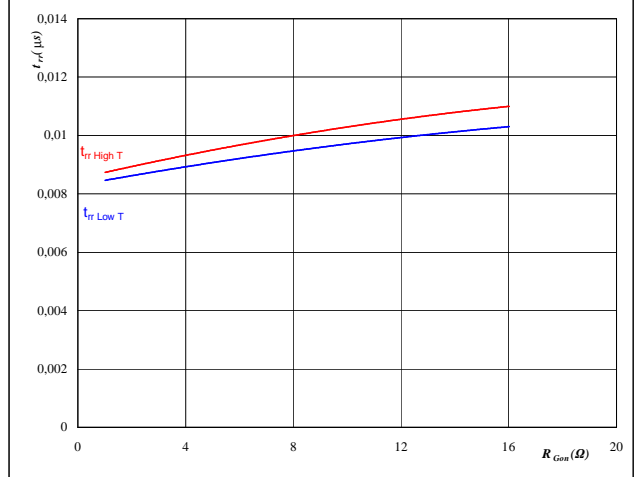
At

$T_j =$	25/125	°C
$V_{CE} =$	700	V
$V_{GE} =$	15	V
$R_{gon} =$	4	Ω

**Figure 12** FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

$T_j =$	25/125	°C
$V_R =$	700	V
$I_F =$	40	A
$V_{GE} =$	15	V

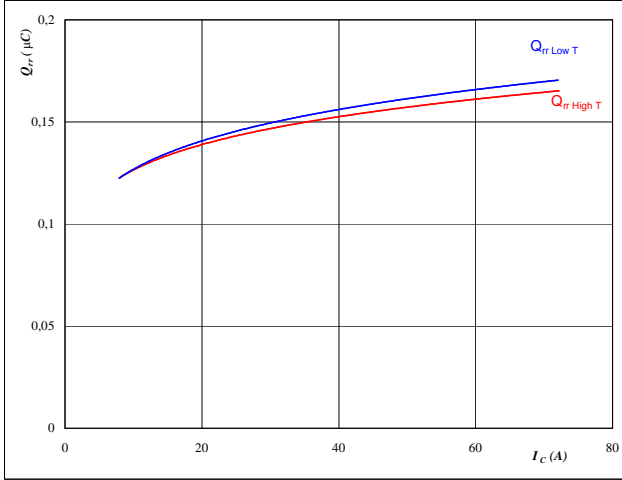


### Input Boost IGBT / Input Boost FWD

**Figure 13** FWD

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$

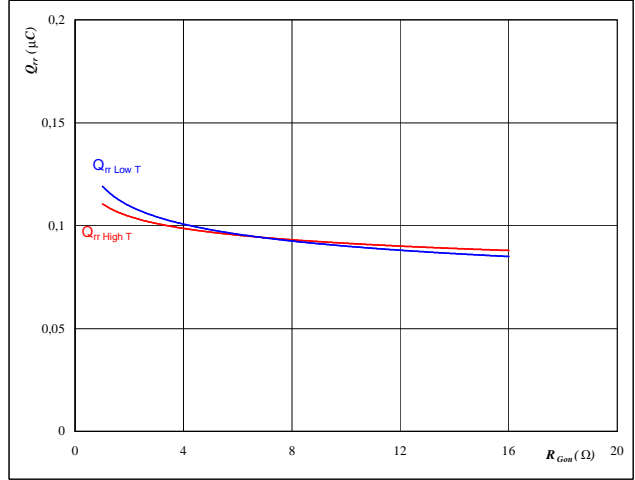


**At**  
 $T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $R_{gon} = 4$  Ω

**Figure 14** FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

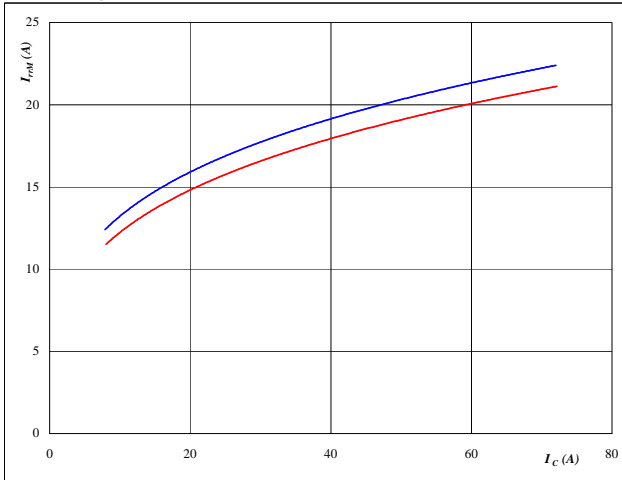


**At**  
 $T_j = 25/125$  °C  
 $V_{ce} = 700$  V  
 $I_F = 40$  A  
 $V_{GE} = 15$  V

**Figure 15** FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$

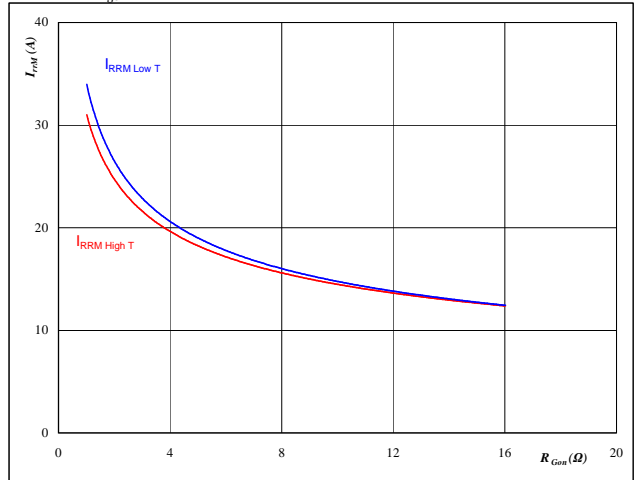


**At**  
 $T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $R_{gon} = 4$  Ω

**Figure 16** FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



**At**  
 $T_j = 25/125$  °C  
 $V_R = 700$  V  
 $I_F = 40$  A  
 $V_{GE} = 15$  V



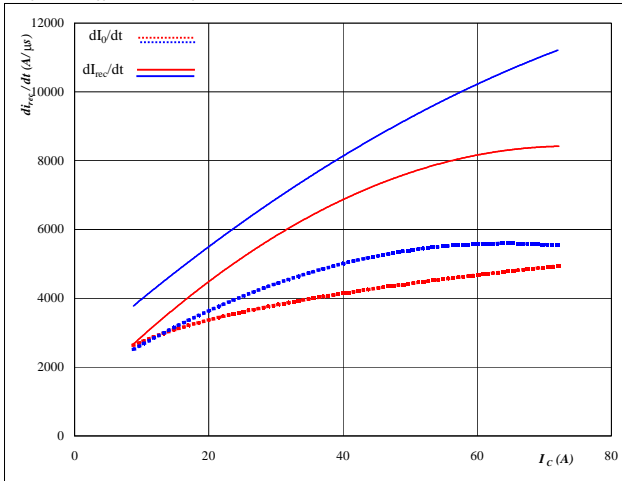


# Input Boost IGBT / Input Boost FWD

**Figure 17** FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$dI_0/dt, dI_{rec}/dt = f(I_c)$$

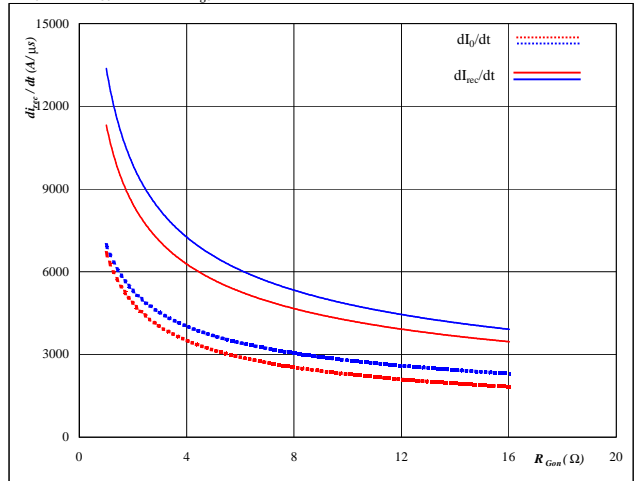


**At**  
 $T_j = 25/125$  °C  
 $V_{CE} = 700$  V  
 $V_{GE} = 15$  V  
 $R_{gon} = 4$  Ω

**Figure 18** FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$dI_0/dt, dI_{rec}/dt = f(R_{gon})$$

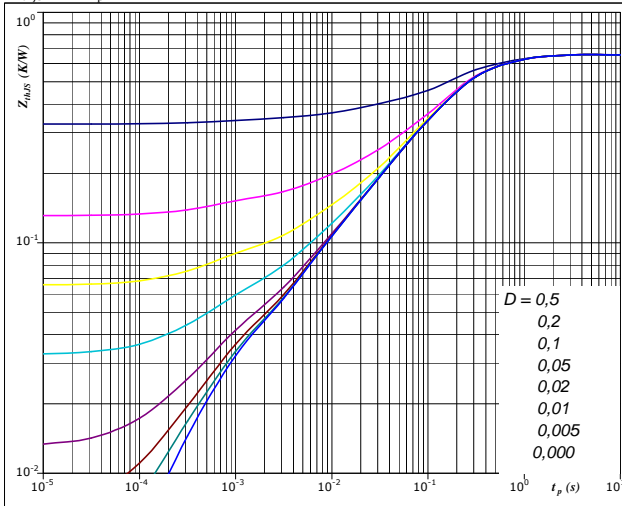


**At**  
 $T_j = 25/125$  °C  
 $V_R = 700$  V  
 $I_F = 40$  A  
 $V_{GE} = 15$  V

**Figure 19** IGBT

IGBT/MOSFET transient thermal impedance as a function of pulse width

$$Z_{thjS} = f(t_p)$$



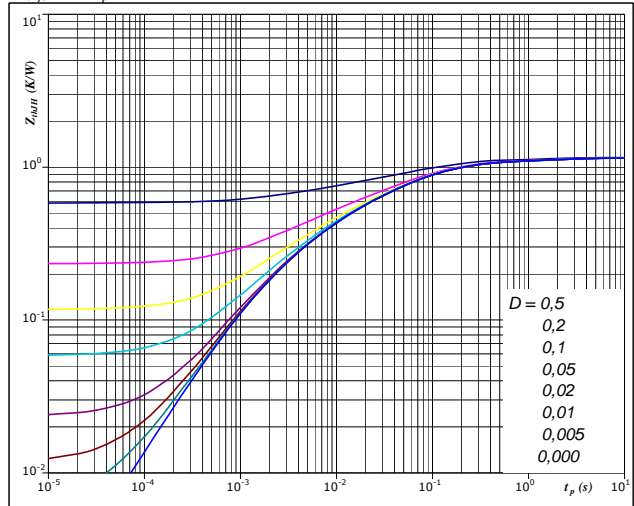
**At**  
 $D = t_p / T$   
 phase-change material Thermal grease  
 $R_{thjS} = 0,65$  K/W  $R_{thjS} = 0,79$  K/W  
 IGBT thermal model values  
 phase-change material Thermal grease  

R (K/W)	Tau (s)	R (K/W)	Tau (s)
0,173	0,561	0,208	0,561
0,381	0,125	0,459	0,125
0,078	0,010	0,094	0,010
-0,003	0,048	-0,004	0,048
0,026	0,001	0,032	0,001

**Figure 20** FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thjS} = f(t_p)$$



**At**  
 $D = t_p / T$   
 phase-change material Thermal grease  
 $R_{thjS} = 1,17$  K/W  $R_{thjS} = 1,36$  K/W  
 FWD thermal model values  
 phase-change material Thermal grease  

R (K/W)	Tau (s)	R (K/W)	Tau (s)
0,043	9,803	0,050	9,803
0,101	0,815	0,118	0,815
0,383	0,098	0,445	0,098
0,308	0,026	0,358	0,026
0,233	0,005	0,271	0,005
0,098	0,001	0,114	0,001

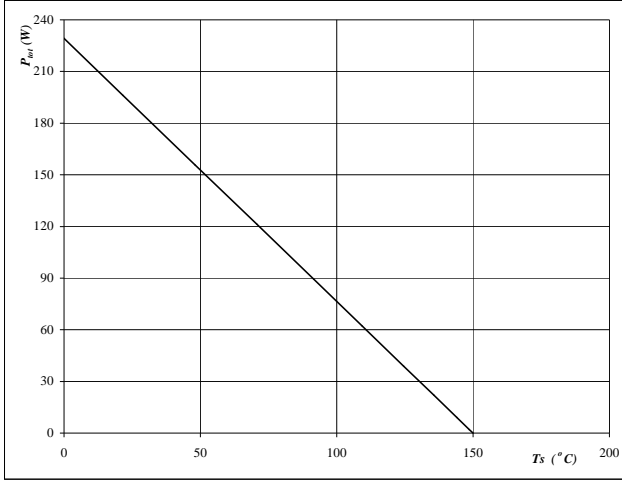


# Input Boost IGBT / Input Boost FWD

**Figure 21** IGBT

**Power dissipation as a function of sink temperature**

$$P_{tot} = f(T_s)$$

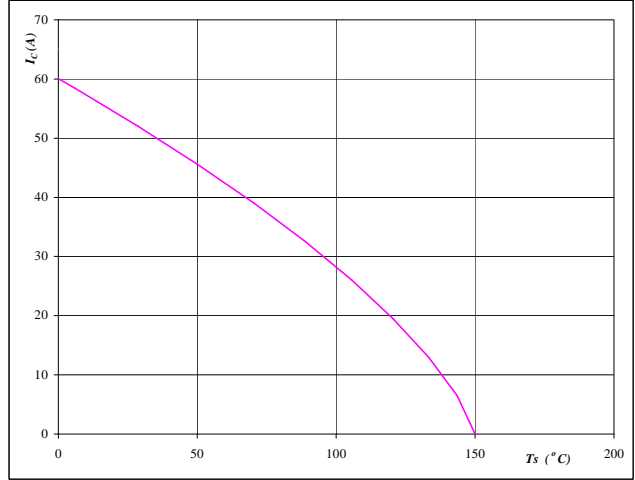


**At**  
T<sub>j</sub> = 150 °C

**Figure 22** IGBT

**Collector/Drain current as a function of sink temperature**

$$I_C = f(T_s)$$

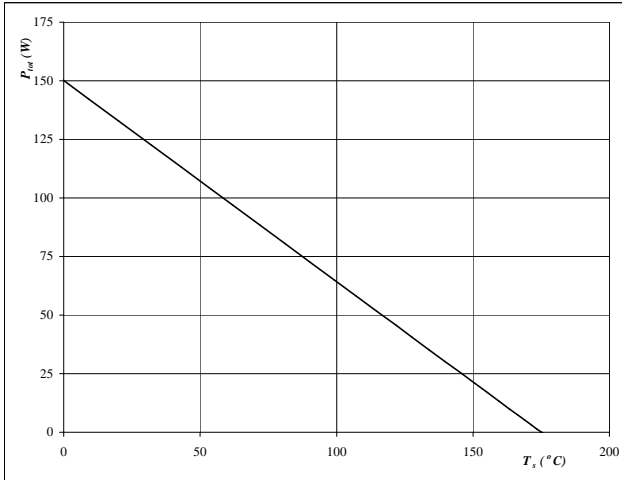


**At**  
T<sub>j</sub> = 150 °C  
V<sub>GE</sub> = 15 V

**Figure 23** FWD

**Power dissipation as a function of sink temperature**

$$P_{tot} = f(T_s)$$

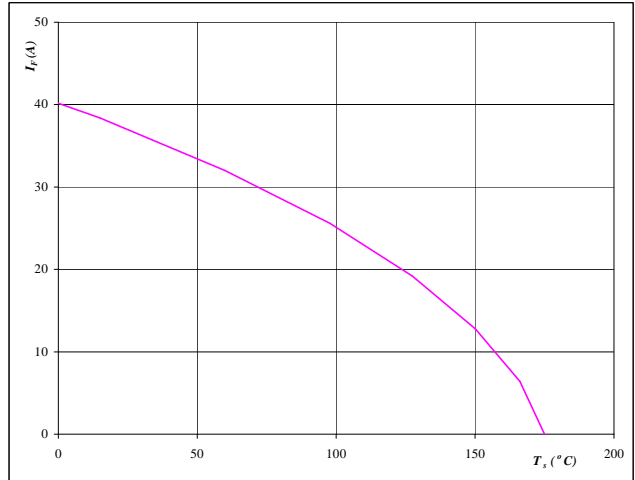


**At**  
T<sub>j</sub> = 175 °C

**Figure 24** FWD

**Forward current as a function of sink temperature**

$$I_F = f(T_s)$$



**At**  
T<sub>j</sub> = 175 °C

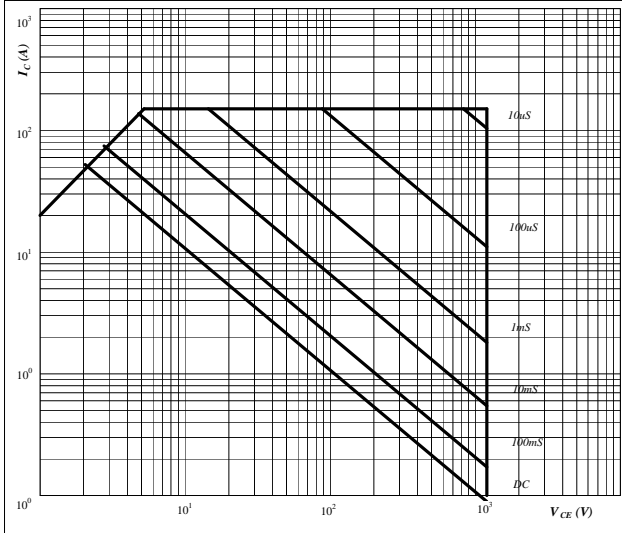


## Input Boost IGBT / Input Boost FWD

**Figure 25** IGBT

Safe operating area as a function of collector-emitter voltage

$$I_C = f(V_{CE})$$

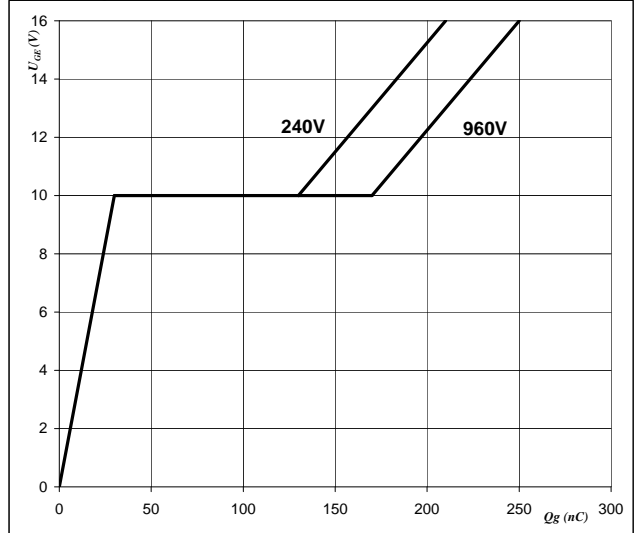


**At**  
 $D =$  single pulse  
 $T_s =$  80 °C  
 $V_{GE} =$  15 V  
 $T_j = T_{jmax}$  °C

**Figure 26** IGBT

Gate voltage vs Gate charge

$$V_{GE} = f(Q_g)$$

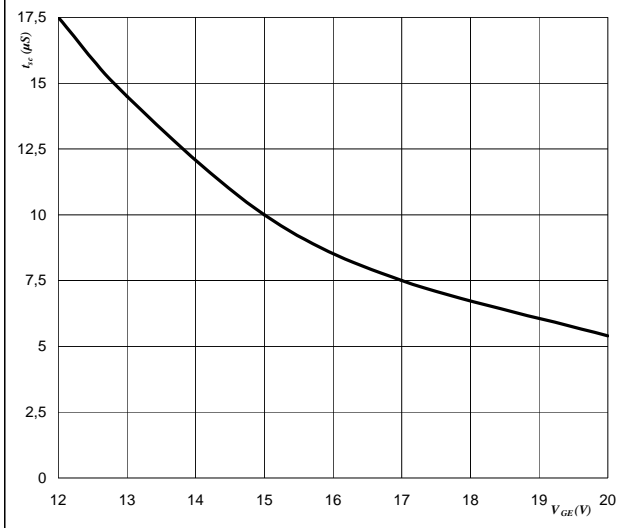


**At**  
 $I_C =$  40 A

**Figure 27** IGBT

Short circuit withstand time as a function of gate-emitter voltage

$$t_{sc} = f(V_{GE})$$

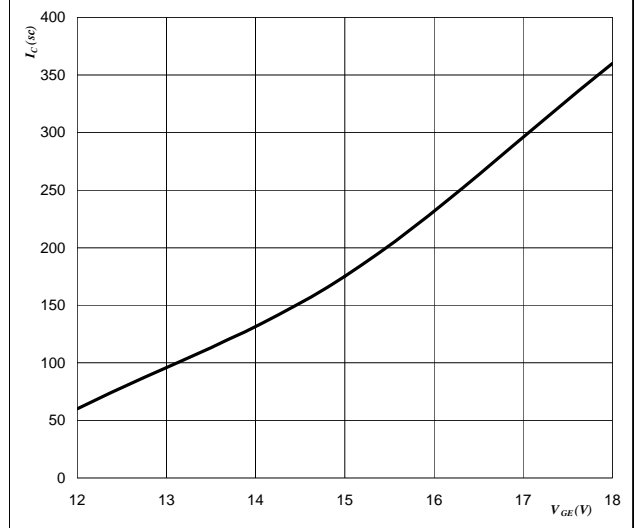


**At**  
 $V_{CE} =$  600 V  
 $T_j \leq$  150 °C

**Figure 28** IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$$I_C = f(V_{GE})$$

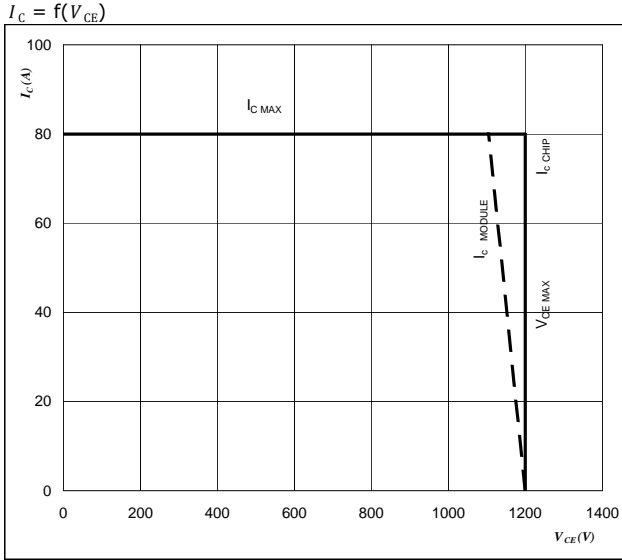


**At**  
 $V_{CE} \leq$  600 V  
 $T_j =$  25 °C



# Input Boost IGBT / Input Boost FWD

**Figure 29** IGBT  
**Reverse bias safe operating area**



**At**  
 $T_{vj} \leq 150$  °C  
 $I_{C\ MAX} = 80$  A  
 $U_{CE\ MAX} = 1200$  V

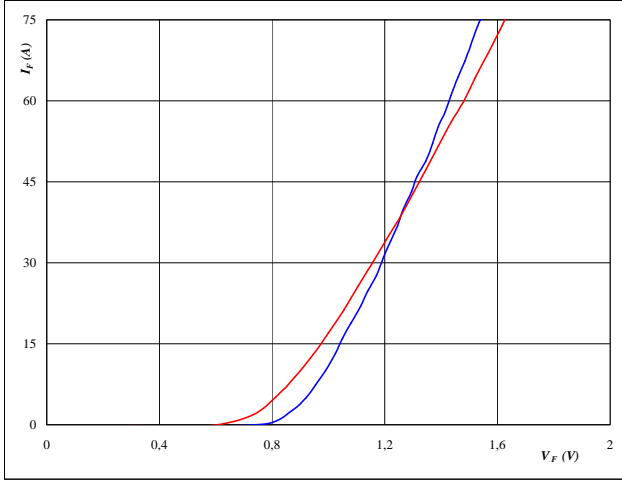


# Bypass Diode \ Input Boost Prot. Diode

**Figure 1** Diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$

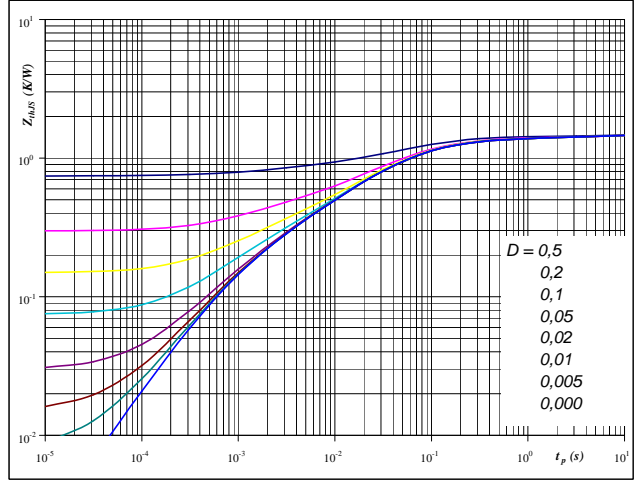


**At**  
 $T_j = 25/125$  °C  
 $t_p = 250$  μs

**Figure 2** Diode

Diode transient thermal impedance as a function of pulse width

$$Z_{thjS} = f(t_p)$$

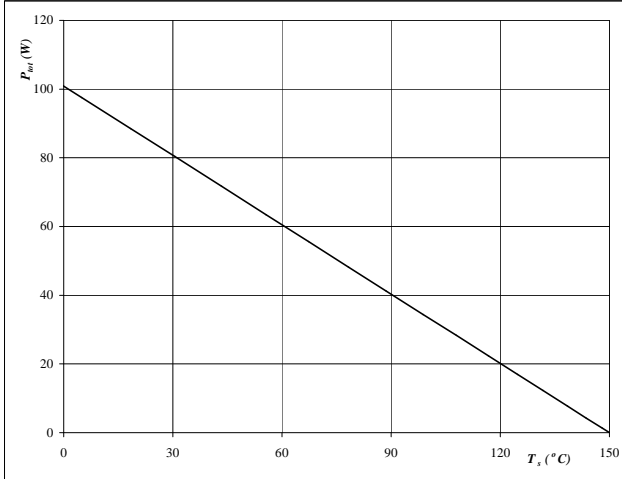


**At**  
 $D = t_p / T$   
 phase-change material      Thermal grease  
 $R_{thjH} = 1,49$  K/W       $R_{thjH} = 1,73$  K/W

**Figure 3** Diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_s)$$

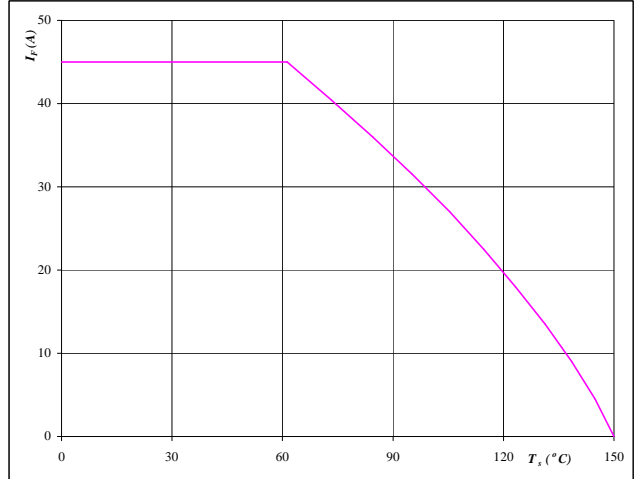


**At**  
 $T_j = 150$  °C

**Figure 4** Diode

Forward current as a function of sink temperature

$$I_F = f(T_s)$$



**At**  
 $T_j = 150$  °C

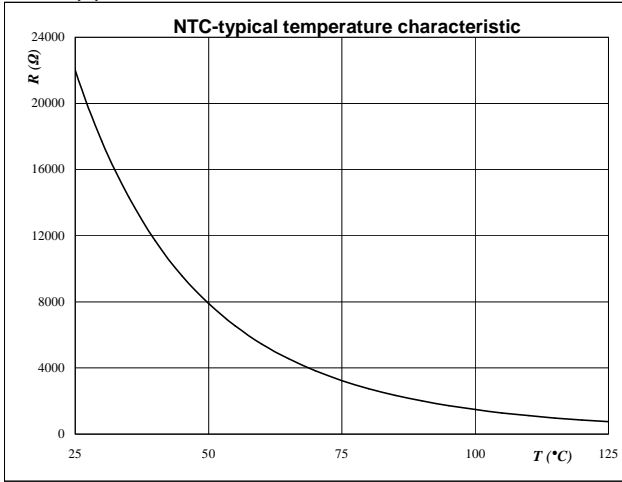


# Thermistor

**Figure 1** Thermistor

**Typical NTC characteristic  
as a function of temperature**

$$R_T = f(T)$$





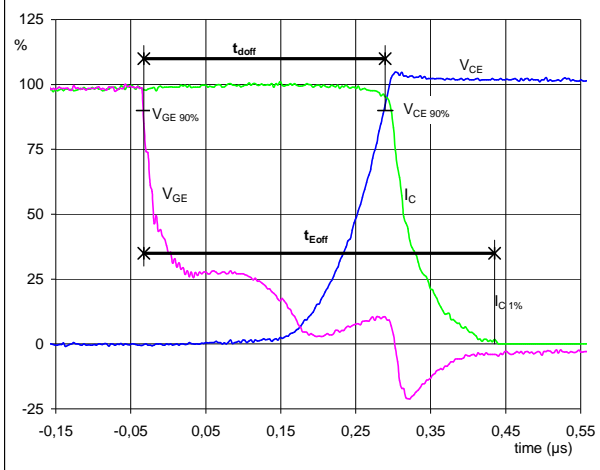
## Switching Definitions Boost

### General conditions

$T_j$	=	125 °C
$R_{gon}$	=	4 Ω
$R_{goff}$	=	4 Ω

**Figure 1** IGBT

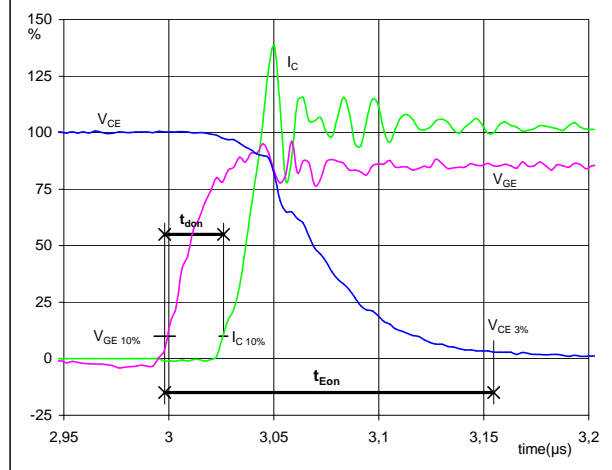
**Turn-off Switching Waveforms & definition of  $t_{doff}$ ,  $t_{Eoff}$**   
( $t_{Eoff}$  = integrating time for  $E_{off}$ )



$V_{GE}$ (0%) =	0	V
$V_{GE}$ (100%) =	15	V
$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_{doff}$ =	0,320	μs
$t_{Eoff}$ =	0,468	μs

**Figure 2** IGBT

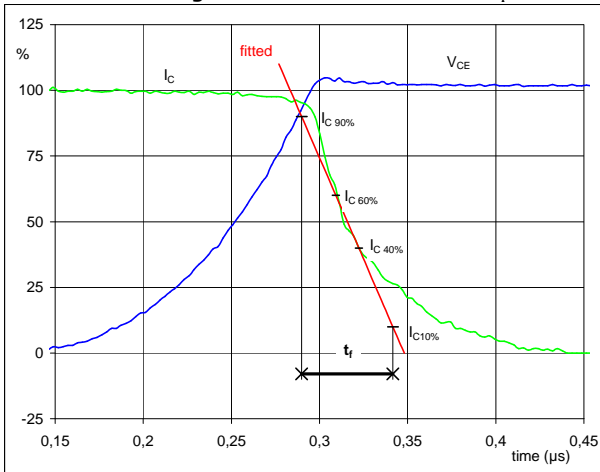
**Turn-on Switching Waveforms & definition of  $t_{donr}$ ,  $t_{Eon}$**   
( $t_{Eon}$  = integrating time for  $E_{on}$ )



$V_{GE}$ (0%) =	0	V
$V_{GE}$ (100%) =	15	V
$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_{donr}$ =	0,027	μs
$t_{Eon}$ =	0,157	μs

**Figure 3** IGBT

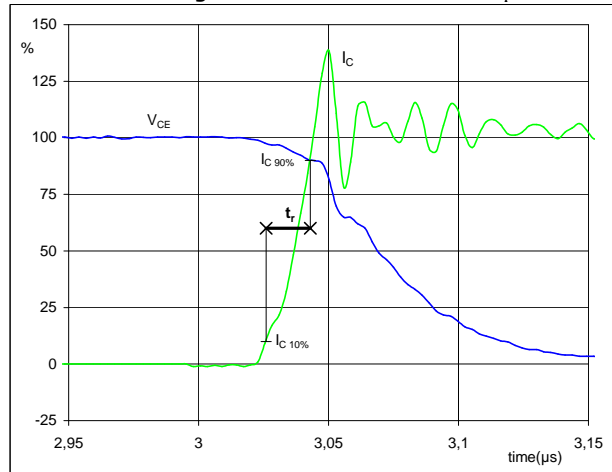
**Turn-off Switching Waveforms & definition of  $t_f$**



$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_f$ =	0,057	μs

**Figure 4** IGBT

**Turn-on Switching Waveforms & definition of  $t_r$**

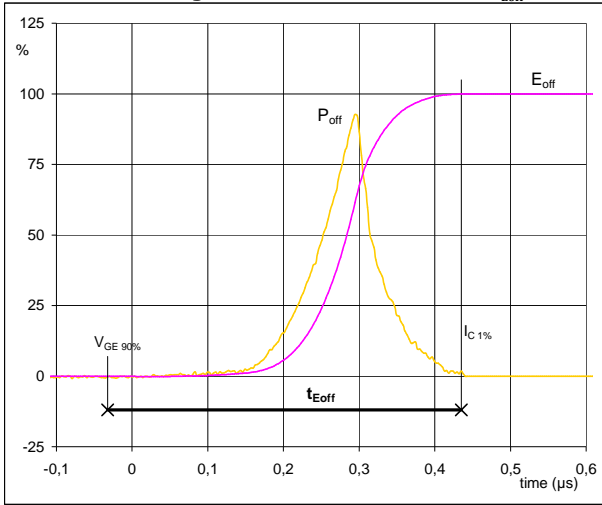


$V_C$ (100%) =	700	V
$I_C$ (100%) =	40	A
$t_r$ =	0,017	μs



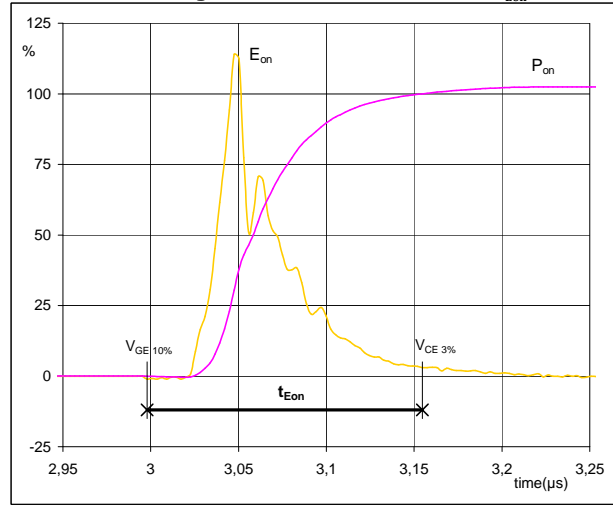
### Switching Definitions Boost

**Figure 5** IGBT  
 Turn-off Switching Waveforms & definition of  $t_{Eoff}$



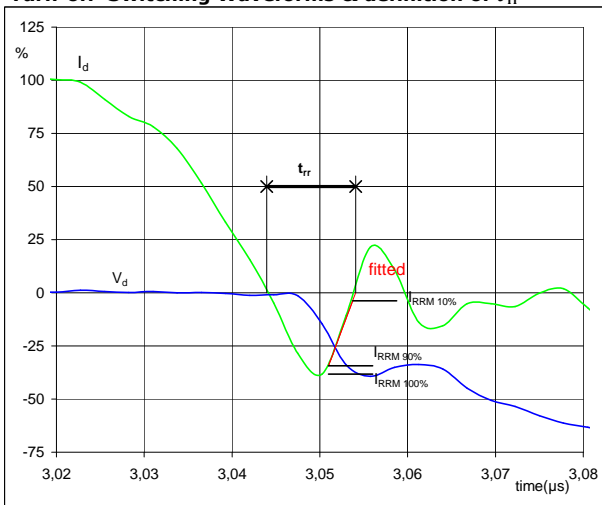
$P_{off} (100\%) = 28,02 \text{ kW}$   
 $E_{off} (100\%) = 2,43 \text{ mJ}$   
 $t_{Eoff} = 0,468 \text{ }\mu\text{s}$

**Figure 6** IGBT  
 Turn-on Switching Waveforms & definition of  $t_{Eon}$



$P_{on} (100\%) = 28,02 \text{ kW}$   
 $E_{on} (100\%) = 1,22 \text{ mJ}$   
 $t_{Eon} = 0,1567 \text{ }\mu\text{s}$

**Figure 7** IGBT  
 Turn-off Switching Waveforms & definition of  $t_{rr}$



$V_C (100\%) = 700 \text{ V}$   
 $I_C (100\%) = 40 \text{ A}$   
 $I_{RRM} (100\%) = -15 \text{ A}$   
 $t_{rr} = 0,009 \text{ }\mu\text{s}$

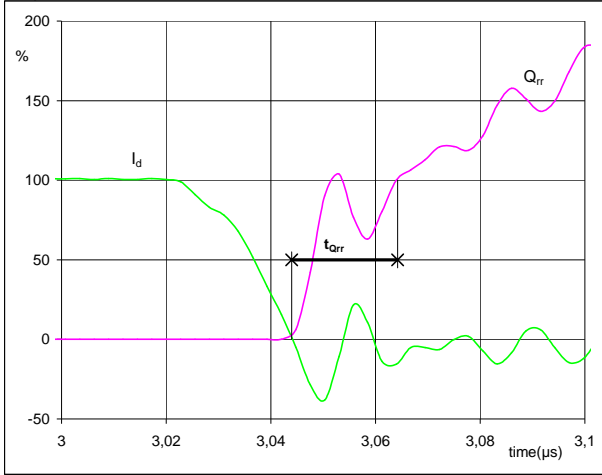




### Switching Definitions Boost

**Figure 8** FWD

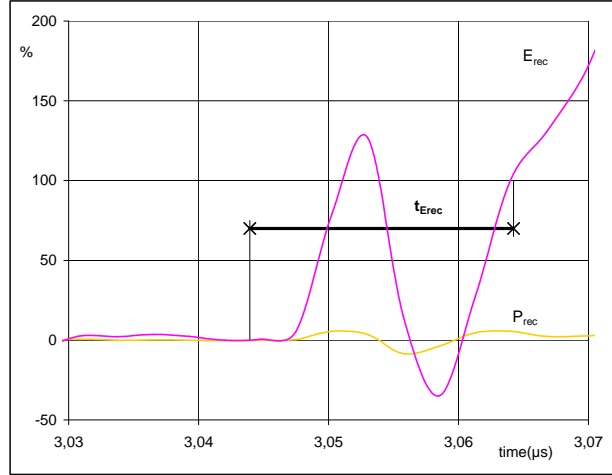
Turn-on Switching Waveforms & definition of  $t_{Qrr}$   
 ( $t_{Qrr}$  = integrating time for  $Q_{rr}$ )



$I_d$ (100%) =	40	A
$Q_{rr}$ (100%) =	0,21	$\mu\text{C}$
$t_{Qrr}$ =	0,02	$\mu\text{s}$

**Figure 9** FWD

Turn-on Switching Waveforms & definition of  $t_{Erec}$   
 ( $t_{Erec}$  = integrating time for  $E_{rec}$ )



$P_{rec}$ (100%) =	28,02	kW
$E_{rec}$ (100%) =	0,07	mJ
$t_{Erec}$ =	0,02	$\mu\text{s}$



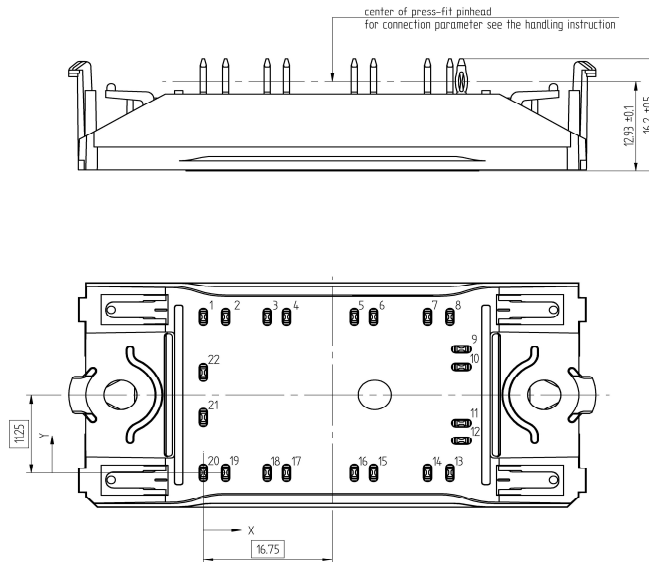
## Ordering Code and Marking - Outline - Pinout

### Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
w/o thermal paste 12mm housing	V23990-P629-L63	P629-L63	P629-L63
w/o thermal paste 12mm housing with Press-fit pins	V23990-P629-L63Y	P629-L63Y	P629-L63Y

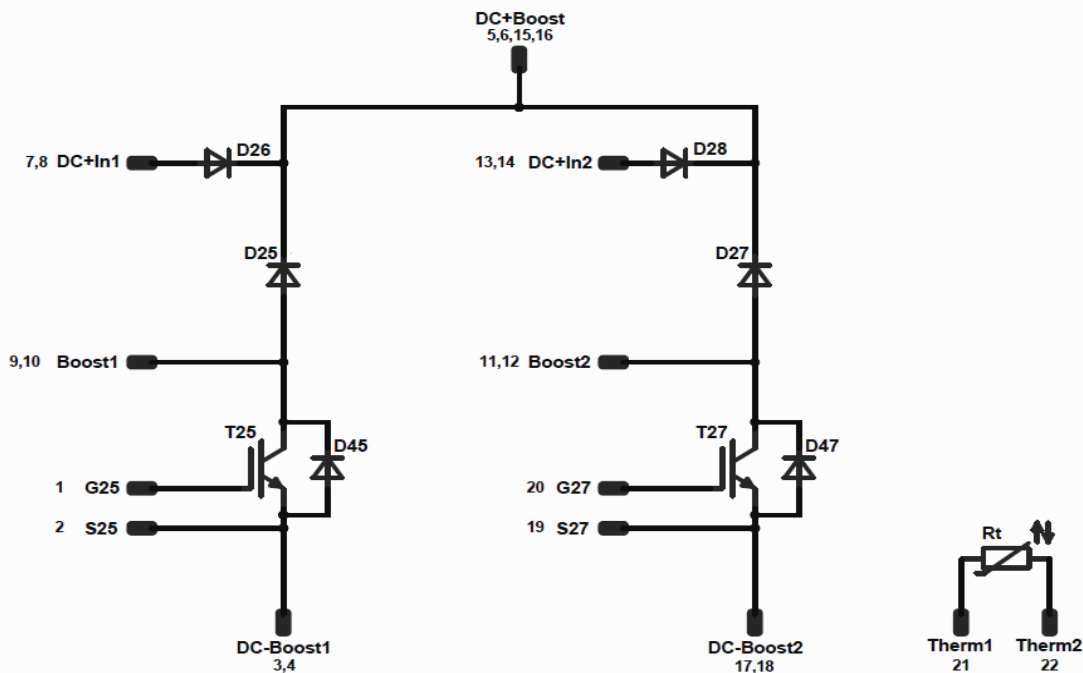
### Outline

Pin table			
Pin	X	Y	Function
1	0	22,5	G25
2	2,9	22,5	S25
3	8,3	22,5	DC-
4	10,8	22,5	Boost1
5	19,6	22,5	DC+Boost
6	22,1	22,5	DC+Boost
7	29,1	22,5	DC+In1
8	32	22,5	DC+In1
9	33,5	17,8	Boost1
10	33,5	15,3	Boost1
11	33,5	7,2	Boost2
12	33,5	4,7	Boost2
13	32	0	DC+In2
14	29,1	0	DC+In2
15	22,1	0	DC+Boost
16	19,6	0	DC+Boost
17	10,8	0	DC-Boost2
18	8,3	0	DC-Boost2
19	2,9	0	S27
20	0	0	G27
21	0	8	Therm1
22	0	14,5	Therm2



Tolerance of pinpositions: ±0,5mm at the end of pins  
Dimension of coordinate axis is only offset without tolerance

### Pinout



### Identification

ID	Component	Voltage	Current	Function	Comment
T25,T27	IGBT	1200V	40A	Input Boost Switch	
D25,D27	FWD	1200V	15A	Input Boost Diode	
D26,D28,D45,D47	Rectifier	1600V	25A	Bypass Diode\Input Boost Prot. Diode	
Rt	NTC	-	-	Thermistor	



Packaging instruction			
Standard packaging quantity (SPQ)	<b>135</b>	>SPQ Standard	<SPQ Sample

Handling instruction
Handling instructions for <i>flow 0</i> packages see vincotech.com website.

Package data
Package data for <i>flow 0</i> packages see vincotech.com website.

Document No.:	Date:	Modification:	Pages
V23990-P629-L63-D3-14	22 Sep. 2015		

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.